

Notice of References Cited

Application/Control No.

10/022,628

Applicant(s)/Patent Under
Reexamination
HRABIK ET AL.

Examiner

Feben M. Haile

Art Unit

2663

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,128,282	10-2000	Liebetreu et al.	370/235
*	B	US-6,885,639	04-2005	Kamiya, Satoshi	370/235
*	C	US-6,895,015	05-2005	Chiang et al.	370/429
*	D	US-2004/0160978	08-2004	Jones et al.	370/461
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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